

Notice of References Cited

Application/Control No.

09/451,207

Applicant(s)/Patent Under
Reexamination
FRANK ET AL.

Examiner

Ahshik Kim

Art Unit

2876

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-5,243,174 | 09-1993 | Veeneman et al. | 235/381 |
| | B | US-5,797,126 | 08-1998 | Helbling et al. | 705/5 |
| | C | US-5,870,718 | 02-1999 | Spector, Donald | 705/26 |
| | D | US-6,067,532 | 05-2000 | Gebb, Lucas | 705/37 |
| | E | US-6,193,155 | 02-2001 | Walker et al. | 235/381 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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